

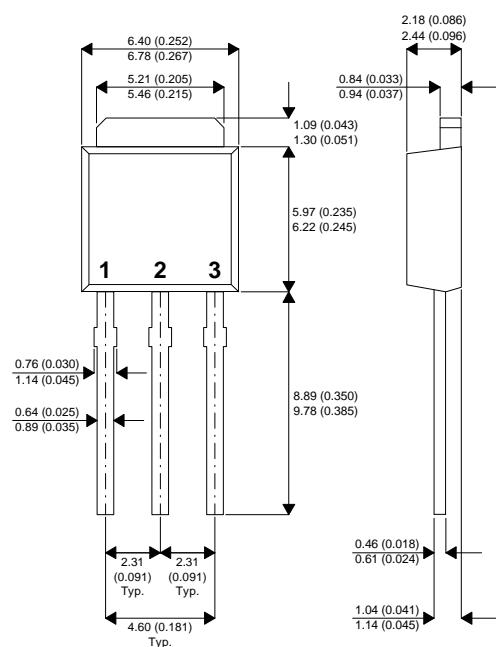


**SEME
LAB**

BUL66A

MECHANICAL DATA

Dimensions in mm



I-PAK(TO251)

Pin 1 – Base

Pin 2 – Collector

Pin 3 – Emitter

ADVANCED DISTRIBUTED BASE DESIGN HIGH VOLTAGE HIGH SPEED NPN SILICON POWER TRANSISTOR

Designed for use in
electronic ballast applications

- SEMEFAB DESIGNED AND DIFFUSED DIE
- HIGH VOLTAGE
- FAST SWITCHING
- HIGH ENERGY RATING

FEATURES

- Multi-base for efficient energy distribution across the chip resulting in significantly improved switching and energy ratings across full temperature range.
- Ion implant and high accuracy masking for tight control of characteristics from batch to batch.
- Triple Guard Rings for improved control of high voltages.

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^\circ\text{C}$ unless otherwise stated)

V_{CBO}	Collector – Base Voltage ($I_E=0$)	350V
V_{CEO}	Collector – Emitter Voltage ($I_B = 0$)	160V
V_{EBO}	Emitter – Base Voltage ($I_C = 0$)	10V
I_C	Continuous Collector Current	16A
$I_{C(PK)}$	Peak Collector Current	25A
I_B	Base Current	5A
P_{tot}	Total Dissipation at $T_{case} = 25^\circ\text{C}$	25W
T_{stg}	Operating and Storage Temperature Range	-55 to +150°C



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ELECTRICAL CHARACTERISTICS ($T_{case} = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
ELECTRICAL CHARACTERISTICS					
$V_{CEO(sus)}$	Collector – Emitter Sustaining Voltage	$I_C = 10\text{mA}$	160		
$V_{(BR)CBO}$	Collector – Base Breakdown Voltage	$I_C = 1\text{mA}$	350		V
$V_{(BR)EBO}$	Emitter – Base Breakdown Voltage	$I_E = 1\text{mA}$	10		
I_{CBO}	Collector – Base Cut-Off Current	$V_{CB} = 350\text{V}$ $T_C = 125^\circ\text{C}$		10	
I_{CEO}	Collector – Emitter Cut-Off Current	$I_B = 0$ $V_{CE} = 150\text{V}$		100	μA
I_{EBO}	Emitter Cut-Off Current	$V_{EB} = 9\text{V}$ $I_C = 0$ $T_C = 125^\circ\text{C}$		10	μA
h_{FE}^*	DC Current Gain	$I_C = 0.3\text{A}$ $V_{CE} = 5\text{V}$	30	80	
		$I_C = 5\text{A}$ $V_{CE} = 5\text{V}$	25	60	
		$I_C = 12\text{A}$ $V_{CE} = 1\text{V}$ $T_C = 125^\circ\text{C}$	5		
$V_{CE(sat)*}$	Collector – Emitter Saturation Voltage	$I_C = 1\text{A}$ $I_B = 0.1\text{A}$.07	0.2
		$I_C = 5\text{A}$ $I_B = 0.5\text{A}$		0.2	0.6
		$I_C = 10\text{A}$ $I_B = 1.0\text{A}$		0.6	1.2
$V_{BE(sat)*}$	Base – Emitter Saturation Voltage	$I_C = 5\text{A}$ $I_B = 0.5\text{A}$		0.95	1.2
		$I_C = 10\text{A}$ $I_B = 1.0\text{A}$		1.2	1.8
DYNAMIC CHARACTERISTICS					
f_t	Transition Frequency	$I_C = 0.2\text{A}$ $V_{CE} = 4\text{V}$		20	MHz
C_{ob}	Output Capacitance	$V_{CB} = 10\text{V}$ $f = 1\text{MHz}$		75	pF

* Pulse test $t_p = 300\mu\text{s}$, $\delta < 2\%$